


Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10566950	NARIHIRO ET AL.
	Examiner	Art Unit
	MICHAEL E NELSON	1794

SEARCHED

Class	Subclass	Date	Examiner
528	423	7/29/2008	Michael E. Nelson
526	259, 310	7/29/2008	Michael E. Nelson
428	690, 917	7/29/2008	Michael E. Nelson
313	502-509	7/29/2008	Michael E. Nelson
275	40, 88-103, E51.001-E51.052	7/29/2008	Michael E. Nelson

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Name Search in eDAN	7/29/2008	Michael E. Nelson
See Attached EAST Search History	7/29/2008	Michael E. Nelson
Structure search from EIC	7/29/2008	Michael E. Nelson
Structure search in STN	7/29/2008	Michael E. Nelson
updated EAST search (see printout)	2/22/2009	D. Garrett
EIC 1700 STIC structure search (see attached)	2/5/2009	D. Garrett

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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